74LV4094 8-stage shift-and-store bus register Rev. 4 — 19 December 2011

Product data sheet

1. General description

The 74LV4094 is a low voltage Si-gate CMOS device and is pin and functional compatible with 74HC4094; 74HCT4094.

The 74LV4094 is an 8-stage serial shift register. It has a storage latch associated with each stage for strobing data from the serial input to parallel buffered 3-state outputs QP0 to QP7. The parallel outputs may be connected directly to common bus lines. Data is shifted on positive-going clock transitions. The data in each shift register stage is transferred to the storage register when the strobe (STR) input is HIGH. Data in the storage register appears at the outputs whenever the output enable (OE) signal is HIGH.

Two serial outputs (QS1 and QS2) are available for cascading a number of 74LV4094 devices. Serial data is available at QS1 on positive-going clock edges to allow high-speed operation in cascaded systems with a fast clock rise time. The same serial data is available at QS2 on the next negative going clock edge. This is used for cascading 74LV4094 devices when the clock has a slow rise time.

2. Features and benefits

- Optimized for low voltage applications: 1.0 V to 3.6 V
- Accepts TTL input levels between V_{CC} = 2.7 V and V_{CC} = 3.6 V
- Typical output ground bounce < 0.8 V at V_{CC} = 3.3 V and T_{amb} = 25 °C
- Typical HIGH-level output voltage (V_{OH}) undershoot: > 2 V at V_{CC} = 3.3 V and T_{amb} = 25 °C
- ESD protection:
 - HBM JESD22-A114E exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

3. Applications

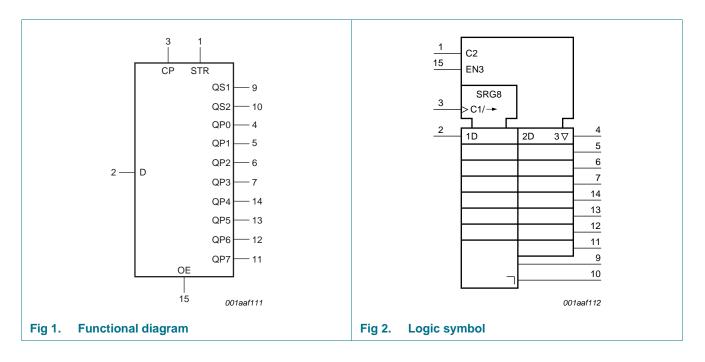
- Serial-to-parallel data conversion
- Remote control holding register



4. Ordering information

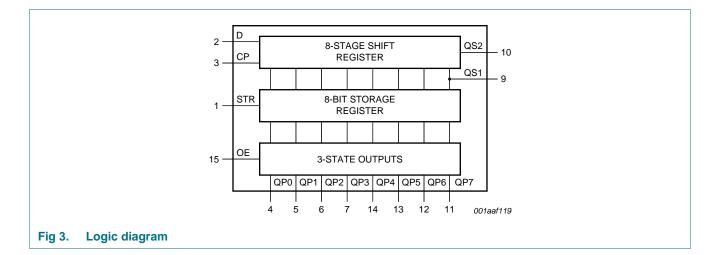
Table 1. Ordering information											
Type number	Package	Package									
	Temperature range	Name	Description	Version							
74LV4094N	–40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4							
74LV4094D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1							
74LV4094DB	–40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1							
74LV4094PW	–40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1							

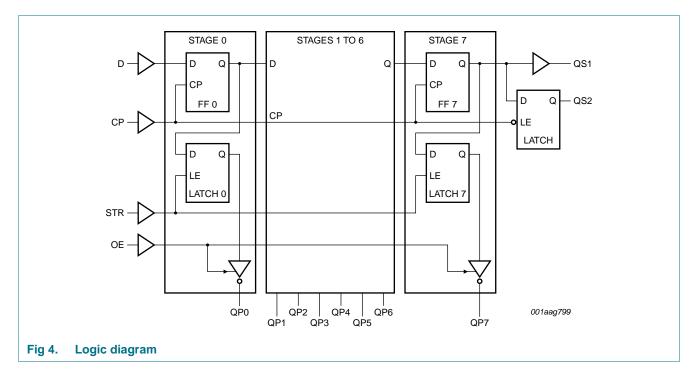
5. Functional diagram



74LV4094

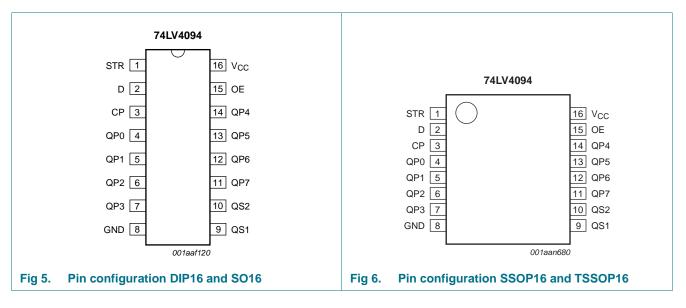
8-stage shift-and-store bus register





6. Pinning information

6.1 Pinning



6.2 Pin description

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Table 2.Pin	description	
Symbol	Pin	Description
STR	1	strobe input
D	2	data input
СР	3	clock input
QP0 to QP7	4, 5, 6, 7, 14, 13, 12, 11	parallel output
V _{SS}	8	ground supply voltage
QS1, QS2	9,10	serial output
OE	15	output enable input
V _{DD}	16	supply voltage

7. Functional description

Table 3.Function table

Inputs			Parallel o	outputs	Serial outputs		
СР	OE	STR	D	QP0	QPn	QS1	QS2
\uparrow	L	х	Х	Z	Z	Q6S	NC
\downarrow	L	Х	Х	Z	Z	NC	Q7S
\uparrow	Н	L	Х	NC	NC	Q6S	NC
\uparrow	Н	Н	L	L	QPn –1	Q6S	NC
\uparrow	Н	Н	Н	Н	QPn –1	Q6S	NC
\downarrow	Н	Н	Н	NC	NC	NC	Q7S

[1] At the positive clock edge, the information in the 7th register stage is transferred to the 8th register stage and the QSn outputs.

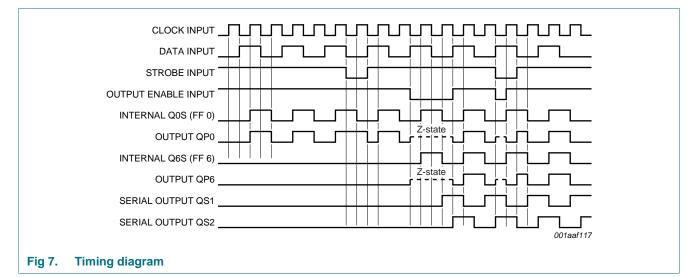
H = HIGH voltage level; L = LOW voltage level; X = don't care;

 \uparrow = positive-going transition; \downarrow = negative-going transition;

Z = HIGH-impedance OFF-state; NC = no change;

Q6S = the data in register stage 6 before the LOW to HIGH clock transition;

Q7S = the data in register stage 7 before the HIGH to LOW clock transition.



8-stage shift-and-store bus register

8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7	V
I _{IK}	input clamping current	$V_{\rm I} < -0.5$ V or $V_{\rm I} > V_{\rm CC}$ + 0.5 V	-	±20	mA
I _{OK}	output clamping current	$V_{\rm O}$ < –0.5 V or $V_{\rm O}$ > $V_{\rm CC}$ + 0.5 V	-	±50	mA
lo	output current	V_{O} = -0.5 V to (V _{CC} + 0.5 V)	-	±25	mA
I _{CC}	supply current		-	+50	mA
I _{GND}	ground current		-50	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 \text{ °C to } +125 \text{ °C}$			
	DIP16 package		<u>[1]</u> _	750	mW
	SO16 package		[2] _	500	mW
	(T)SSOP16 package		<u>[3]</u>	500	mW

[1] For DIP16 package: P_{tot} derates linearly with 12 mW/K above 70 $^\circ\text{C}.$

[2] For SO16 package: P_{tot} derates linearly with 8 mW/K above 70 $^\circ\text{C}.$

[3] For SSOP16 and TSSOP16 packages: Ptot derates linearly with 5.5 mW/K above 60 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

•		,				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		[<u>1</u>] 1.0	3.3	3.6	V
VI	input voltage		0	-	V _{CC}	V
Vo	output voltage		0	-	V _{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	°C
$\Delta t / \Delta V$	input transition rise and fall rate	V_{CC} = 1.0 V to 2.0 V	-	-	500	ns/V
		V_{CC} = 2.0 V to 2.7 V	-	-	200	ns/V
		V_{CC} = 2.7 V to 3.6 V	-	-	100	ns/V

[1] The static characteristics are guaranteed from V_{CC} = 1.2 V to V_{CC} = 5.5 V, but LV devices are guaranteed to function down to V_{CC} = 1.0 V (with input levels GND or V_{CC}).

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	–40 °C to 85 °C			–40 °C to +125 °C		Unit	
			Min	Typ <mark>[1]</mark>	Max	Min	Max		
V _{IH}	HIGH-level	$V_{CC} = 1.2 V$	V _{CC}	0.6	-	V _{CC}	-	V	
	input voltage	$V_{CC} = 2.0 V$	1.4	-	-	1.4	-	V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2.0	-	-	2.0	-	V	
V _{IL}	LOW-level	V _{CC} = 1.2 V	-	0.4	GND	-	GND	V	
	input voltage	$V_{CC} = 2.0 V$	-	-	0.6	-	0.6	V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	-	0.8	-	0.8	V	
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL} ; all pins							
	output voltage	$I_{O} = -100 \ \mu A; \ V_{CC} = 1.2 \ V$	-	1.2	-	-	-	V	
		$I_{O} = -100 \ \mu A; \ V_{CC} = 2.0 \ V$	1.8	2.0	-	1.8	-	V	
		$I_O = -100 \ \mu\text{A}; \ V_{CC} = 2.7 \ \text{V}$	2.5	2.7	-	2.5	-	V	
		$I_{O} = -100 \ \mu A; \ V_{CC} = 3.0 \ V$	2.8	3.0	-	2.8	-	V	
		$V_I = V_{IH} \text{ or } V_{IL}; \text{ pins QPn}$							
	$I_{O} = -6 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.40	2.82	-	2.20	-	V		
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL} ; all pins							
	output voltage	I_{O} = 100 µA; V_{CC} = 1.2 V	-	0	-	-	-	V	
		I_{O} = 100 µA; V_{CC} = 2.0 V	-	0	0.2	-	0.2	V	
		$I_{O} = 100 \ \mu A; \ V_{CC} = 2.7 \ V$	-	0	0.2	-	0.2	V	
		$I_{O} = 100 \ \mu A; \ V_{CC} = 3.0 \ V$	-	0	0.2	-	0.2	V	
		$V_I = V_{IH} \text{ or } V_{IL}; \text{ pins QPn}$							
		$I_{O} = 6 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	0.25	0.40	-	0.50	V	
I	input leakage current	$V_{I} = V_{CC}$ or GND; $V_{CC} = 3.6$ V	-	-	±1.0	-	±1.0	μΑ	
oz	OFF-state output current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{IH} \text{ or } V_{IL}; V_{O} = V_{CC} \text{ or } GND; \\ V_{CC} = 3.6 \ V \end{array}$	-	-	±5.0	-	±10.0	μΑ	
сс	supply current		-	-	20.0	-	160	μA	
۵lcc	additional supply	per input; $V_I = V_{CC} - 0.6 V$;	-	-	500.0	-	850	μΑ	
	current	$V_{CC} = 2.7 V \text{ to } 3.6 V$							

[1] All typical values are measured at $T_{amb} = 25 \ ^{\circ}C$.

11. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); $C_L = 50 \text{ pF}$ unless otherwise specified; for test circuit see <u>Figure 12</u>.

Symbol	Parameter	Conditions		-40	°C to 85	°C	–40 °C to +125 °C		
				Min	Typ[1]	Max	Min	Max	
pd	propagation	CP to QS1; see Figure 8	[3]						
	delay	V _{CC} = 1.2 V		-	90	-	-	-	ns
		$V_{CC} = 2.0 V$		-	31	58	-	70	ns
		$V_{CC} = 2.7 V$		-	23	43	-	51	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	-	17	34	-	41	ns
		$V_{CC} = 3.3 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	14	-	-	-	ns
		CP to QS2; see Figure 8	[3]						
		V _{CC} = 1.2 V		-	80	-	-	-	ns
		$V_{CC} = 2.0 V$		-	27	51	-	61	ns
		$V_{CC} = 2.7 V$		-	20	38	-	45	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$		-	14	30	-	36	ns
		$V_{CC} = 3.3 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	[2]	-	13	-	-	-	ns
		CP to QPn; see Figure 8	[3]						
		V _{CC} = 1.2 V		-	115	-	-	-	ns
	$V_{CC} = 2.0 V$		-	39	75	-	90	ns	
		$V_{CC} = 2.7 V$		-	29	55	-	66	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	-	22	44	-	53	ns
		$V_{CC} = 3.3 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	18	-	-	-	ns
		STR to QPn; see Figure 9	[3]						
		V _{CC} = 1.2 V		-	105	-	-	-	ns
		$V_{CC} = 2.0 V$		-	36	68	-	82	ns
		$V_{CC} = 2.7 V$		-	26	50	-	60	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	-	20	40	-	48	ns
		$V_{CC} = 3.3 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	17	-	-	-	ns
ən	enable time	OE to QPn; see Figure 11	[4]						
		V _{CC} = 1.2 V		-	100	-	-	-	ns
		$V_{CC} = 2.0 V$		-	34	65	-	77	ns
		$V_{CC} = 2.7 V$		-	25	48	-	56	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	-	19	38	-	45	ns
dis	disable time	OE to QPn; see Figure 11	[5]						
		$V_{CC} = 1.2 V$		-	65	-	-	-	ns
		$V_{CC} = 2.0 V$		-	24	40	-	49	ns
		$V_{CC} = 2.7 V$		-	18	32	-	37	ns
		V_{CC} = 3.0 V to 3.6 V	[2]	-	14	26	-	30	ns

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Symbol	Parameter	Conditions		-40) °C to 85	°C	–40 °C t	o +125 °C	Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	
N	pulse width	CP HIGH or LOW; see Figure 8							
		$V_{CC} = 2.0 V$		34	9	-	41	-	ns
		$V_{CC} = 2.7 V$		25	6	-	30	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	20	5	-	24	-	ns
		STR HIGH; see Figure 9							
		$V_{CC} = 2.0 V$		34	9	-	41	-	ns
		$V_{CC} = 2.7 V$		25	6	-	30	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	20	5	-	24	-	ns
su	set-up time	D to CP; see Figure 10							
		$V_{CC} = 1.2 V$		-	25	-	-	-	ns
		$V_{CC} = 2.0 V$		22	9	-	26	-	ns
		$V_{CC} = 2.7 V$		16	6	-	19	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	13	5	-	15	-	ns
		CP to STR; see Figure 9							
		$V_{CC} = 1.2 V$		-	50	-	-	-	ns
		$V_{CC} = 2.0 V$		43	17	-	51	-	ns
		$V_{CC} = 2.7 V$		31	13	-	38	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	25	10	-	30	-	ns
h	hold time	D to CP; see Figure 10							
		$V_{CC} = 1.2 V$		-	-10	-	-	-	ns
		$V_{CC} = 2.0 V$		5	-4	-	+5	-	ns
		$V_{CC} = 2.7 V$		5	-3	-	+5	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[2]	5	-2	-	+5	-	ns
		CP to STR; see Figure 9							
		$V_{CC} = 1.2 V$		-	-25	-	-	-	ns
		$V_{CC} = 2.0 V$		5	-9	-	+5	-	ns
		$V_{CC} = 2.7 V$		5	-6	-	+5	-	ns
		V_{CC} = 3.0 V to 3.6 V	[2]	5	-5	-	+5	-	ns
nax	maximum	CP; see Figure 8							
	frequency	$V_{CC} = 2.0 V$		14	52	-	12	-	MHz
		$V_{CC} = 2.7 V$		19	70	-	16	-	MH:
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$		24	87	-	20	-	MH:
		$V_{CC} = 3.3 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	[2]	-	95	-	-	-	MH

Dynamic characteristics ... continued Table 7.

8-stage shift-and-store bus register

Voltages a	/oltages are referenced to GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit see Figure 12.								
Symbol	Parameter	Conditions	nditions -40 °C to 85 °C		°C	–40 °C to +125 °C		Unit	
				Min	Typ <mark>[1]</mark>	Max	Min	Max	
C _{PD}	power dissipation capacitance	C_L = 50 pF; f = 1 MHz; V _I = GND to V _{CC}	[7]	-	83	-	-	-	pF

Table 7. Dynamic characteristics ... continued

[1] All typical values are measured at $T_{amb} = 25 \ ^{\circ}C$.

- [2] All typical values are measured at V_{CC} = 3.3 V.
- [3] t_{pd} is the same as t_{PLH} and t_{PHL} .
- [4] t_{en} is the same as t_{PZH} and t_{PZL} .
- [5] t_{dis} is the same as t_{PLZ} and t_{PHZ} .
- [6] t_t is the same as t_{THL} and t_{TLH} .
- [7] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where:

 f_i = input frequency in MHz;

fo = output frequency in MHz;

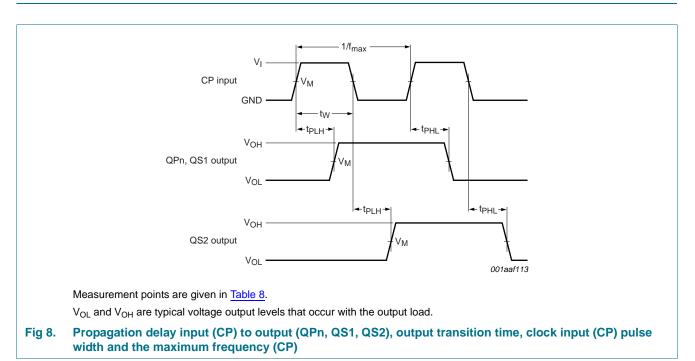
 C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V;

N = number of inputs switching;

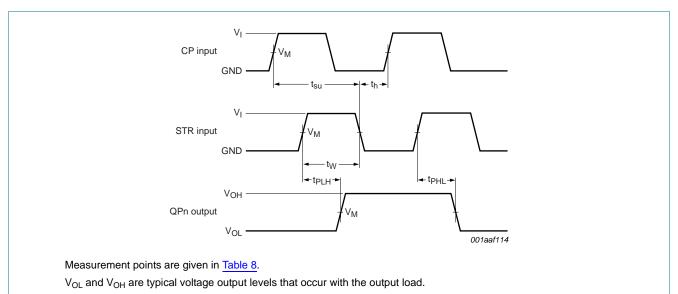
 $\Sigma(C_L \times V_{CC}^2 \times f_0)$ = sum of outputs.

12. Waveforms

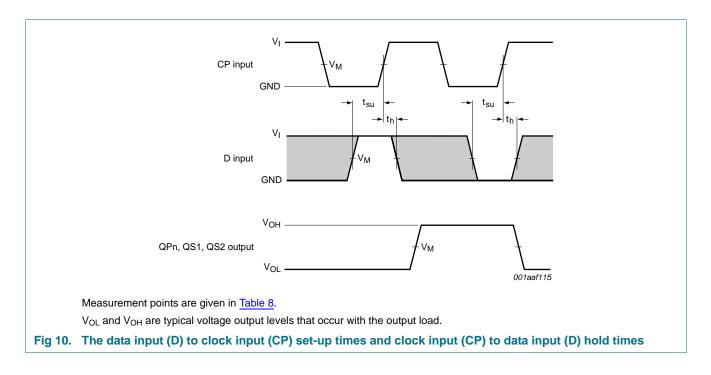


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8-stage shift-and-store bus register







74LV4094

8-stage shift-and-store bus register

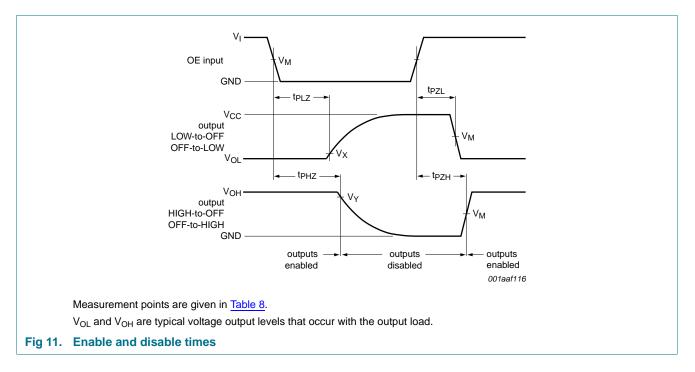


Table 8. Measurement points

Supply voltage	Input	Output	Output				
V _{CC}	V _M	V _M	V _X	V _Y			
< 2.7 V	0.5V _{CC}	0.5V _{CC}	$V_{OL} + 0.1 V_{CC}$	$V_{OH} - 0.1 V_{CC}$			
2.7 V to 3.6 V	1.5 V	1.5 V	V _{OL} + 0.3 V	V _{OH} – 0.3 V			

74LV4094 Product data sheet

74LV4094

8-stage shift-and-store bus register

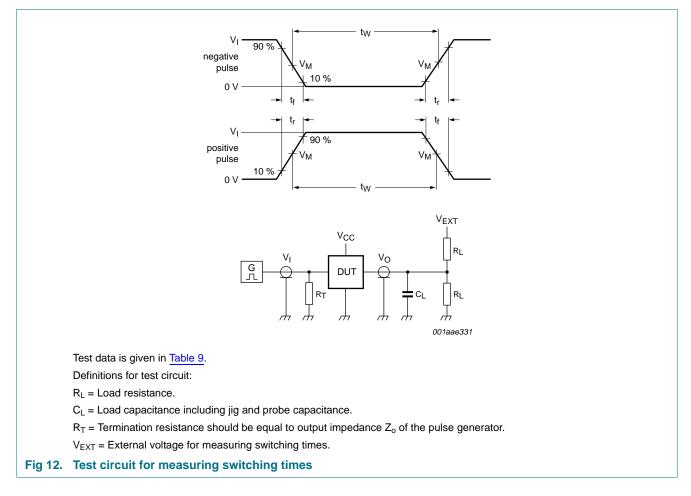


Table 9. Test data

Supply voltage	Input		Load	Load		V _{EXT}		
V _{cc}	VI	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}	
< 2.7 V	V _{CC}	\leq 2.5 ns	50 pF	1 kΩ	open	GND	2V _{CC}	
2.7 V to 3.6 V	2.7 V	\leq 2.5 ns	15 pF, 50 pF	1 kΩ	open	GND	2V _{CC}	

8-stage shift-and-store bus register

13. Package outline

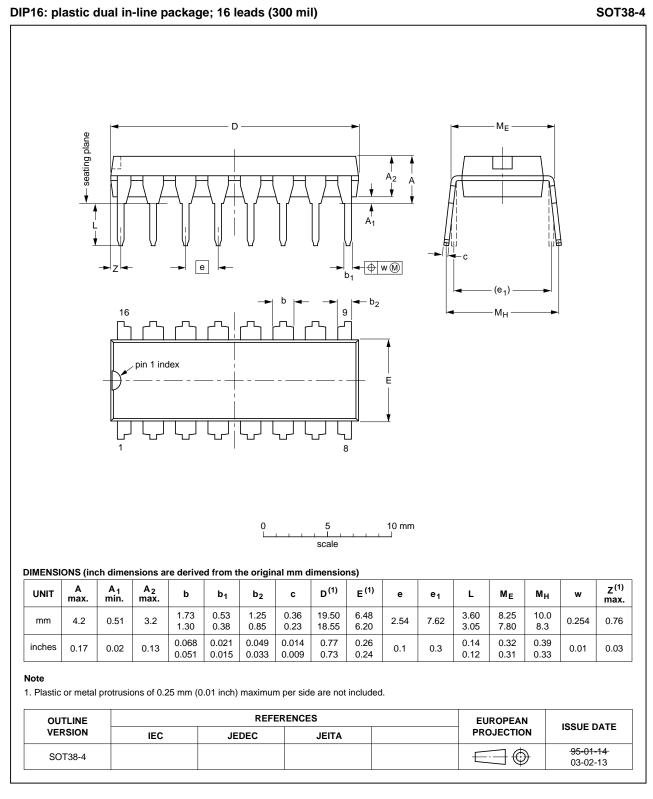


Fig 13. Package outline SOT38-4 (DIP16)

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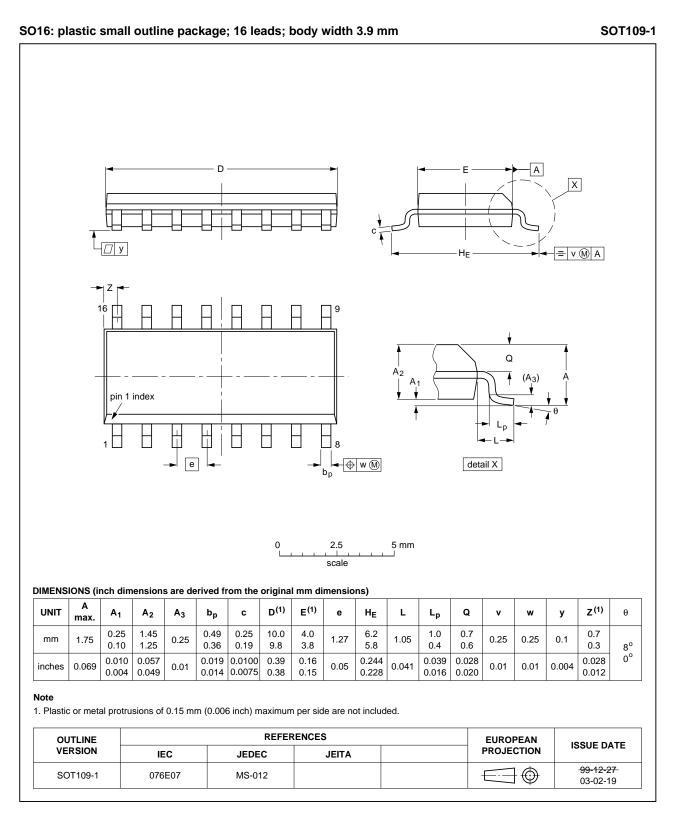


Fig 14. Package outline SOT109-1 (SO16)

8-stage shift-and-store bus register

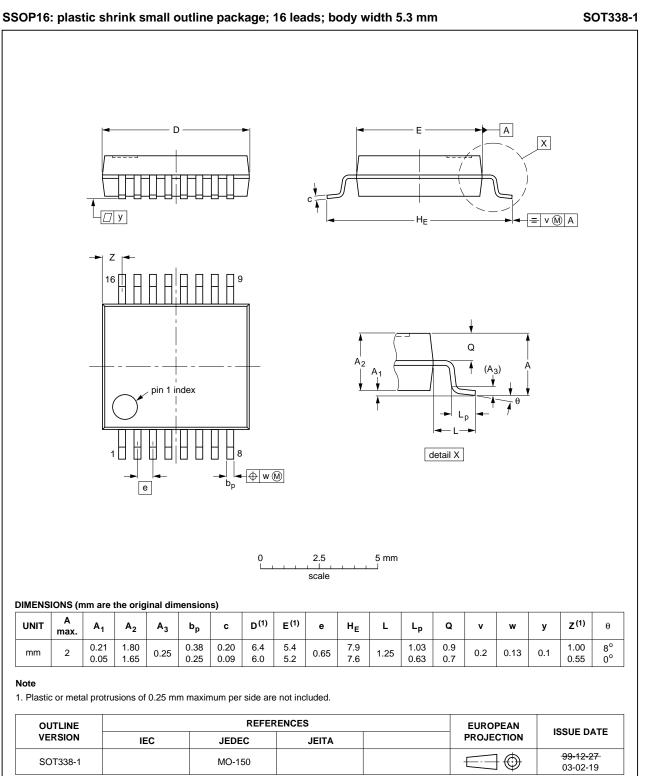


Fig 15. Package outline SOT338-1 (SSOP16)

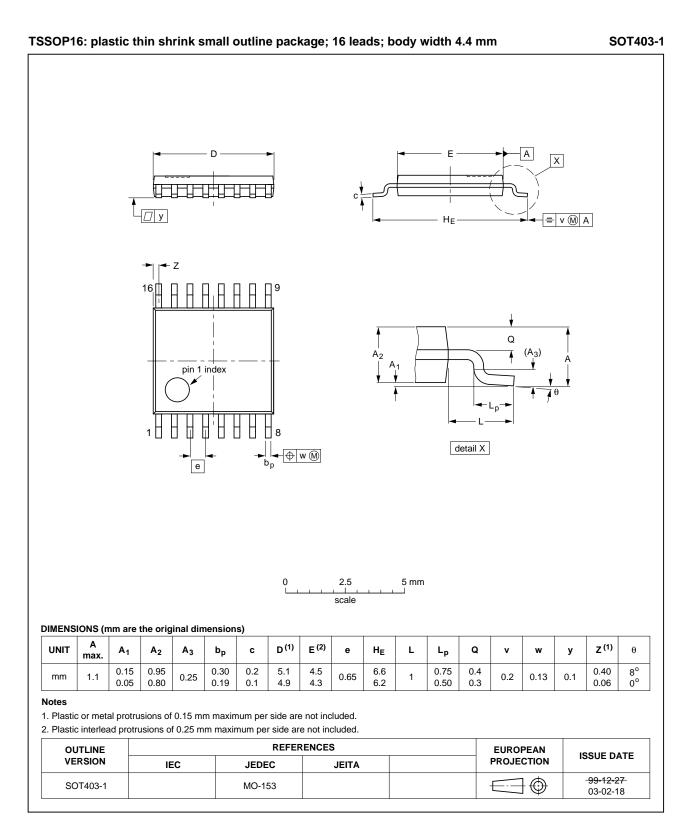


Fig 16. Package outline SOT403-1 (TSSOP16)

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14. Abbreviations

Abbreviations
Description
Complementary Metal Oxide Semiconductor
Device Under Test
ElectroStatic Discharge
Human Body Model
Machine Model
Transistor-Transistor Logic

15. Revision history

Document IDRelease dateData sheet statusChange noticeSupersedes74LV4094 v.420111219Product data sheet-74LV4094 v.3Modifications:• Legal pages updated74LV4094 v.274LV4094 v.320110307Product data sheet-74LV4094 v.274LV4094 v.220060629Product data sheet-74LV4094 v.174LV4094 v.119980623Product specification	Table 11.Revision h	listory		
Modifications:• Legal pages updated.74LV4094 v.320110307Product data sheet-74LV4094 v.274LV4094 v.220060629Product data sheet-74LV4094 v.1	Document ID	Release date Data sheet status	Change notice	Supersedes
74LV4094 v.3 20110307 Product data sheet - 74LV4094 v.2 74LV4094 v.2 20060629 Product data sheet - 74LV4094 v.1	74LV4094 v.4	20111219 Product data sheet	-	74LV4094 v.3
74LV4094 v.2 20060629 Product data sheet - 74LV4094 v.1	Modifications:	 Legal pages updated. 		
	74LV4094 v.3	20110307 Product data sheet	-	74LV4094 v.2
74LV4094 v.1 19980623 Product specification	74LV4094 v.2	20060629 Product data sheet	-	74LV4094 v.1
	74LV4094 v.1	19980623 Product specification	-	-

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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